

<b>Notice of References Cited</b>	Application/Control No. 10/029,769	Applicant(s)/Patent Under Reexamination RILEY ET AL.	
	Examiner Tan Dean D. Nguyen	Art Unit 3629	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,728,748	04-2004	Mangipudi et al.	718/105
*	B	US-2003/0126001	07-2003	Northcutt et al.	705/8
	C	US-			
	D	US-			
	E	US-			
	F	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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**NON-PATENT DOCUMENTS**

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